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(Ga_{0.71}B_{0.29})PO₄ with a high-cristobalitetype structure refined from powder data

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Key indicators: powder X-ray study; T = 293 K; mean $\sigma(P-O) = 0.003$ Å; disorder in main residue; R factor = 0.076; wR factor = 0.129.

Gallium boron phosphate, $(Ga_{0.71}B_{0.29})PO_4$, was synthesized by a high-temperature solid-state reaction method. The crystal structure is isostructural with the tetragonal high-cristobalite structure with space group $P\overline{4}$ which is built from alternating $Ga(B)O_4$ and PO_4 tetrahedra interconnected by sharing the common O-atom vertices, resulting in a three-dimensional structure with two-dimensional six-membered-ring tunnels running along the a and b axes.

Related literature

For information on cristobalite structures, see: Achary et al. (2003). For borophosphate structures, see: Ewald et al. (2007); Mi et al. (1999); Schmidt et al. (2004); Schulze (1934); Dachille & Glasser (1959); Mackenzie et al. (1959). For the catalytic properties of BPO₄, see: Moffat (1978); Moffat & Schmidtmeyer (1986); Mooney (1956); Morey et al. (1983); Tada et al. (1987); Tartarelli et al. (1970). For crystallographic background, see: Finger et al. (1994)); Thompson et al. (1987).

Experimental

Crystal data

 $\begin{array}{lll} ({\rm Ga}_{0.71}{\rm B}_{0.29}){\rm PO}_4 & Z=2 \\ M_r=147.61 & {\rm Cu}\; K\alpha_1, \, {\rm Cu}\; K\alpha_2 \; {\rm radiation} \\ {\rm Tetragonal}, \; P\overline{4} & \lambda=1.5405, \, 1.5443 \; \mathring{\rm A} \\ a=4.7343 \; (1) \; \mathring{\rm A} & T=293 \; {\rm K} \\ c=7.0896 \; (4) \; \mathring{\rm A} & {\rm flat\; sheet, } 10\times 10 \; {\rm mm} \\ V=158.90 \; (1) \; \mathring{\rm A}^3 & \end{array}$

Data collection

 $\begin{array}{ll} \mbox{Rigaku-D/max automatic powder} & \mbox{Data collection mode: reflection} \\ \mbox{diffractometer} & \mbox{Scan method: step} \\ \mbox{Specimen mounting: packed powder} & 2\theta_{\min} = 15.03^{\circ}, 2\theta_{\max} = 100.02^{\circ}, \\ \mbox{2}\theta_{\text{step}} = 0.01^{\circ} \end{array}$

Refinement

 $\begin{array}{lll} R_{\rm p} = 0.076 & \chi^2 = 3.204 \\ R_{\rm wp} = 0.129 & 8500 \ {\rm data \ points} \\ R_{\rm exp} = 0.072 & 35 \ {\rm parameters} \\ R(F^2) = 0.07586 & 2 \ {\rm restraints} \end{array}$

Table 1
Selected bond lengths (Å).

(Ga/B)1-O2 ⁱ	1.7079 (5)	P1-O1	1.499 (3)
(Ga/B)2-O1 ⁱⁱ	1.6979 (5)		

Symmetry codes: (i) x, y, z - 1; (ii) x - 1, y, z.

Cell refinement: *GSAS* (Larson & Von Dreele, 2004); data reduction: *GSAS*; program(s) used to refine structure: *GSAS* (Larson & Von Dreele, 2004); molecular graphics: *DIAMOND* (Brandenburg, 2005); software used to prepare material for publication: *GSAS*.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: BR2131).

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(Ga_{0.71}B_{0.29})PO₄ with a high-cristobalite-type structure refined from powder data

Y.-X. Huang, J.-Y. Liu, J.-X. Mi and J.-T. Zhao

Comment

The high-cristobalite boron phosphate has long been used as an effective catalyst for various organic reactions such as hydration, dehydration, oligomerization (Moffat, 1978; Moffat & Schmidtmeyer, 1986; Morey *et al.*, 1983; Tada *et al.*, 1987; Tartarelli *et al.*, 1970). The catalytic activities depend on the ratio of P/B and surface area. In the case of excess B content, BPO₄ catalysts consist predominately of Lewis acid sites, and show catalytic efficiencies for the dehydration. In contrast, in a region consisting of excess phosphorus P content, BPO₄ catalysts have more Brønsted acid sites and exhibit catalytic activities for hydration. Applying trivalent cations to partially substitute boron may vary the ratio of P/B and modify the catalytic property. The possibility of modifying the catalytic properties by varieties of P/B ratio and searching for new phases in the borophosphate system intrigue us to investigate systems containing larger trivalent metal cations. In our previous investigations, a series of compounds with boron partially substituted by transition metals, such as Mn, Fe, Co, Ni, and Cu, has been characterized with low cristobalite type structure (Mi *et al.*, 1999). When we applied a smaller trivalent element Ga to modify the BPO₄, the occupancy of Ga is more than 50%, while less than 50% for transition metal compounds (*M* = Mn, Fe, Co, Ni, and Cu). In consequence, the structure of (Ga_{0.71}B_{0.29})PO₄ are high-cristobalite structure instead of low-cristobalite type structure.

The (Ga, B)1–O and (Ga, B)2–O bond distances are 1.7079 (5) Å and 1.6979 (5) Å in the (Ga, B)O₄ tetrahedra which are significantly larger than the B–O bond value of 1.463 Å in BPO₄ (Schmidt *et al.*, 2004), but smaller than the bond values of 1.829 Å for Ga–O bond in GaPO₄ (Achary *et al.*, 2003), indicating that boron and gallium occupy the same position. After refining both the atomic occupation number and displacement parameters, it results in the ratio of Ga:B = 0.71:0.29. In turn, the Ga:P is 1.42:2, which is quite good agreement with that (Ga:P = 3:4) in the reactants for obtaining the pure phase. The introduction of gallium in the compound led to the deformation of all the tetrahedra and quite anisotropic expansion of the structure which results in lowering symmetry from space group $I\overline{A}$ of BPO₄ to $P\overline{A}$ for the new compound.

Experimental

The title compound has been synthesized *via* high temperature solid state reaction method and the structure refined from X-ray powder diffraction data. A mixture of H_3BO_3 , $NH_4H_2PO_4$, and Ga_2O_3 with molar ratio of B:Ga:P = 12:3:4 was well

supplementary materials

ground and reacted first at 973 K for 4 h, then cooled down to room temperature and reground again, pressed into pellets and reacted at 1373 K for 8 h, at last shut down the furnace and cooled down to room temperature. The extra B_2O_3 in the products were washed out by hot water.

Refinement

The cell parameters were obtained by least-square fits of the powder diffractometer data using silicon (a = 5.4308 Å) as an internal standard. Although the powder pattern and cell parameters are quite different from BPO₄, the starting atomic positional parameters can still be derived from the prototype BPO₄ (Schmidt *et al.*, 2004). During the initial refinement, the unreasonable negative thermal parameters for the B position are indicative of partial substitutions by Ga. The boron position then were assumed to be occupied by two kinds of atoms and the occupacies were allowed to vary during the subsequent refinements. Because it is difficult to refine both the occupation numbers and atomic displacement parameters at the same time, a two-step process was applied to refine the occupancy numbers and atomic displacement parameters. At the begining, all the atomic displacement parameters were set to one value to refine the occupancy number, then fixed the occupany number to refine the displacement parameters. Both processes were performed alternately several times till reasonable values for both atomic occupancies and displacement parameters were obtained. Due to the individual refinement, the standard deviations given by the program are much too small to be a realistic estimate of the uncertainty.

Figures



Fig. 1. Experimental (points) and calculated (lines) X-ray diffraction patterns of $(Ga_{0.71}B_{0.29})PO_4$. The difference profile is given at the bottom. The Bragg positions are indicated by the vertical marker below the observed pattern.

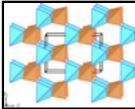


Fig. 2. The crystal structure of $(Ga_{0.71}B_{0.29})PO_4$ viewed along the *a*-axis. $(Ga_7B_9)O_4$ tetrahedra: blue, PO_4 tetrahedra: orange.

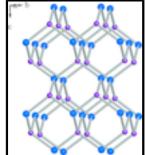


Fig. 3. Topological figure for the network of $(Ga_{0.71}B_{0.29})PO_4$, oxygen atoms were omitted for clarity. Ga(B) atoms: blue spheres, P atoms: purple spheres.

gallium boron phosphate

Crystal data

 $(Ga_{0.71}B_{0.29})PO_4$ Z = 2

 $M_r = 147.61$ F(000) = 140.4 Tetragonal, $P\overline{4}$ $D_x = 3.084 \text{ Mg m}^{-3}$

Hall symbol: P -4 Cu $K\alpha_1$, Cu $K\alpha_2$ radiation, $\lambda = 1.540500$, 1.544300 Å

a = 4.7343 (1) Å T = 293 K c = 7.0896 (4) Å white

 $V = 158.90 (1) \text{ Å}^3$ flat sheet, $10 \times 10 \text{ mm}$

Data collection

Rigaku-D/max automatic powder Scan method: step

diffractometer Scan method. step

graphite $2\theta_{min} = 15.03^{\circ}, 2\theta_{max} = 100.02^{\circ}, 2\theta_{step} = 0.01^{\circ}$ Specimen mounting: packed powder pellet DUMMY Data collection mode: reflection DUMMY

Refinement

 $\chi^2 = 3.204$

Least-squares matrix: full 8500 data points

 $R_p = 0.076$ Profile function: Thompson et al. (1987); Finger et

al. (1994); Stephens et al. (1999)

 $R_{\rm wp} = 0.129$ 35 parameters $R_{\rm exp} = 0.072$ 2 restraints $R(F^2) = 0.07586$ $(\Delta/\sigma)_{\rm max} = 0.001$

Background function: The background function is a

cosine Fourier series with a leading constant term. I_b = B_1 + ΣB_j cos[P*(j-1)] (j=2-9), here P = 20, B_j (j = 1-9) values are given below: 1: 935.903 2: -1634.98 3: 1422.47 4: -1094.93 5: 681.394 6: -358.046 7:

116.953 8: -17.2104 9: -22.9558

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (\mathring{A}^2)

	x	y	z	$U_{\rm iso}*/U_{\rm eq}$	Occ. (<1)
Ga1	0.5	0.5	0.0	0.0347 (12)*	0.7002 (4)
Ga2	0.0	0.0	0.5	0.0406 (11)*	0.7179 (3)
P1	0.5	0.0	0.7456 (5)	0.0447 (12)*	
O1	0.7299 (3)	0.1326(3)	0.6304 (5)	0.0493 (15)*	
O2	0.6286 (3)	0.7718 (4)	0.8669 (5)	0.0511 (16)*	
B1	0.5	0.5	0.0	0.0347 (12)*	0.2998 (4)
B2	0.0	0.0	0.5	0.0406 (11)*	0.2821 (3)

supplementary materials

(Ga/B)1—P1 ⁱ	2.9759 (8)	(Ga/B)2—O1 ^{ix}	1.6979 (5)
(Ga/B)1—P1 ⁱⁱ	2.9759 (8)	(Ga/B)2—O1 ^x	1.6979 (5)
(Ga/B)1—P1 ⁱⁱⁱ	2.9759 (8)	P1—O1	1.499 (3)
(Ga/B)1—P1 ^{iv}	2.9759 (8)	P1—O1 ^{ix}	1.499 (3)
(Ga/B)1—O2 ⁱ	1.7079 (5)	P1—O2 ^{xi}	1.509 (3)
(Ga/B)1—O2 ⁱⁱⁱ	1.7079 (5)	P1—O2 ^{xii}	1.509 (3)
(Ga/B)1—O2 ^v	1.7079 (5)	B1—O2 ⁱ	1.7079 (5)
(Ga/B)1—O2 ^{vi}	1.7079 (5)	B1—O2 ⁱⁱⁱ	1.7079 (5)
(Ga/B)2—P1 ^{vii}	2.9386 (8)	B1—O2 ^v	1.7079 (5)
(Ga/B)2—P1	2.9386 (8)	B1—O2 ^{vi}	1.7079 (5)
(Ga/B)2—P1 ^{viii}	2.9386 (8)	B2—O1 ^{vii}	1.6979 (5)
(Ga/B)2—P1 ⁱⁱⁱ	2.9386 (8)	B2—O1 ⁱⁱⁱ	1.6979 (5)
(Ga/B)2—O1 ^{vii}	1.6979 (5)	B2—O1 ^{ix}	1.6979 (5)
(Ga/B)2—O1 ⁱⁱⁱ	1.6979 (5)	B2—O1 ^x	1.6979 (5)
O2 ⁱ —(Ga/B)1—O2 ⁱⁱⁱ	107.765 (2)	O2 ^{xi} —P1—O2 ^{xii}	110.502 (4)
O2 ⁱ —(Ga/B)1—O2 ^v	112.941 (3)	(Ga/B)2 ^{xiii} —O1—P1	133.541 (1)
O2 ⁱ —(Ga/B)1—O2 ^{vi}	107.765 (2)	P1—O1—B2 ^{xiii}	133.541 (1)
O2 ⁱⁱⁱ —(Ga/B)1—O2 ^v	107.765 (2)	$(Ga/B)1^{xiv}$ — $O2$ — $P1^{xv}$	135.267 (1)
O2 ⁱⁱⁱ —(Ga/B)1—O2 ^{vi}	112.941 (3)	P1 ^{xv} —O2—B1 ^{xiv}	135.267 (1)
O2 ^v —(Ga/B)1—O2 ^{vi}	107.765 (2)	O2 ⁱ —B1—O2 ⁱⁱⁱ	107.765 (2)
O1 ^{vii} —(Ga/B)2—O1 ⁱⁱⁱ	107.239 (2)	O2 ⁱ —B1—O2 ^v	112.941 (3)
O1 ^{vii} —(Ga/B)2—O1 ^{ix}	114.035 (3)	O2 ⁱ —B1—O2 ^{vi}	107.765 (2)
O1 ^{vii} —(Ga/B)2—O1 ^x	107.239 (2)	O2 ⁱⁱⁱ —B1—O2 ^v	107.765 (2)
O1 ⁱⁱⁱ —(Ga/B)2—O1 ^{ix}	107.239 (2)	O2 ⁱⁱⁱ —B1—O2 ^{vi}	112.941 (3)
O1 ⁱⁱⁱ —(Ga/B)2—O1 ^x	114.035 (3)	O2 ^v —B1—O2 ^{vi}	107.765 (2)
O1 ^{ix} —(Ga/B)2—O1 ^x	107.239 (2)	O1 ^{vii} —B2—O1 ⁱⁱⁱ	107.239 (2)
O1—P1—O1 ^{ix}	113.942 (3)	O1 ^{vii} —B2—O1 ^{ix}	114.035 (3)
O1—P1—O2 ^{xi}	108.506 (2)	O1 ^{vii} —B2—O1 ^x	107.239 (2)
O1—P1—O2 ^{xii}	107.696 (2)	$O1^{iii}$ — $B2$ — $O1^{ix}$	107.239 (2)
$O1^{ix}$ — $P1$ — $O2^{xi}$	107.696 (2)	O1 ⁱⁱⁱ —B2—O1 ^x	114.035 (3)
O1 ^{ix} —P1—O2 ^{xii}	108.506 (2)	$O1^{ix}$ — $B2$ — $O1^{x}$	107.239 (2)
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Symmetry codes: (i) x, y, z-1; (ii) x, y+1, z-1; (iii) y, -x+1, -z+1; (iv) y+1, -x+1, -z+1; (v) -x+1, -y+1, z-1; (vi) -x+1, x, -z+1; (vii) x-1, y, z; (viii) y, -x, -z+1; (ix) -x+1, -y, z; (x) -y, x-1, -z+1; (xi) x, y-1, z; (xii) -x+1, -y+1, z; (xiii) x+1, y, z; (xiv) x, y, z+1; (xv) x, y+1, z.

Fig. 1

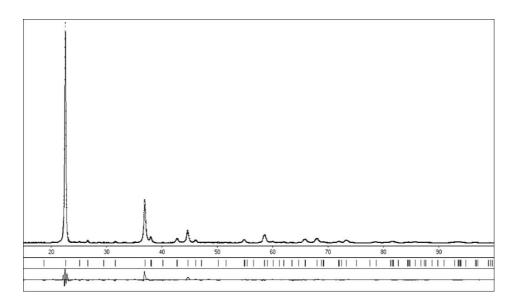


Fig. 2

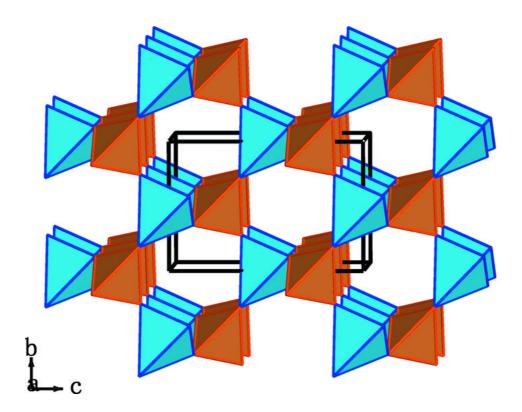


Fig. 3

